

Issue Classification



Application/Control No.

09723161

Applicant(s)/Patent under Reexamination

ESAKA, SATOSHI

Examiner

Nguyen, Huy D

Art Unit

2617

ORIGINAL

CLASS

SUBCLASS

455

406

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

455

435.1

456.1

INTERNATIONAL CLASSIFICATION

CLAIMED

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NON-CLAIMED

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(Assistant Examiner)

8/15/06

(Date)

Amelia Badi

(Legal Instruments Examiner)

(Date)

SUPERVISORY PATENT EXAMINER

(Primary Examiner)

8/17/06

(Date)

Total Claims Allowed:

17

O.G.
Print Claim(s)

1

O.G.
Print Figure

3